

## THYRISTORS

Silicon thyristors in metal envelopes, intended for general purpose single-phase or three-phase mains operation.

The series consists of reverse polarity types (anode to stud) identified by a suffix R:BTW23-600R to 1600R.

## QUICK REFERENCE DATA

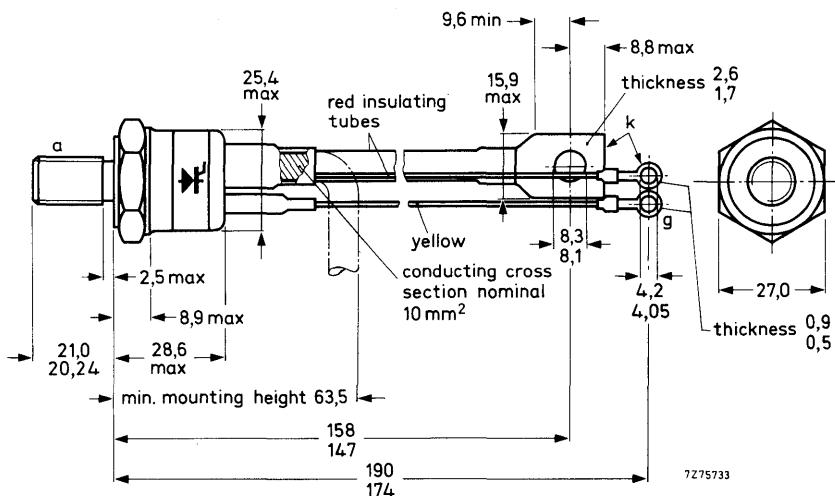
	BTW23-600R	800R	1000R	1200R	1400R	1600R
Repetitive peak voltages $V_{DRM} = V_{RRM}$	max. 600	800	1000	1200	1400	1600 V
Average on-state current				$I_T(AV)$	max. 90 A	
R.M.S. on-state current				$I_T(RMS)$	max. 140 A	
Non-repetitive peak on-state current				$I_{TSM}$	max. 2000 A	
Rate of rise of off-state voltage that will not trigger any device				$dV_D/dt$	< 200 V/ $\mu$ s	
On request (see ordering note on page 4)				$dV_D/dt$	< 1000 V/ $\mu$ s	

## MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-94: with metric M12 stud ( $\varnothing$  12 mm); e.g. BTW23-600R.

Types with  $\frac{1}{2}$  in x 20 UNF stud ( $\varnothing$  12,7 mm) are available on request. These are indicated by the suffix U: e.g. BTW23-600RU.



Net mass: 134 g

Diameter of clearance hole: max. 13,0 mm

Torque on nut: min. 9 Nm (90 kg cm)

max. 17,5 Nm (175 kg cm)

Supplied with device: 1 nut, 1 lock washer

Nut dimensions across the flats;

M12 : 19 mm

$\frac{1}{2}$  in x 20 UNF: 19 mm

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

**Anode to cathode**

		BTW23-600R	800R	1000R	1200R	1400R	1600R	
Non-repetitive peak voltages ( $t \leq 10$ ms)	$V_{DSM}/V_{RSM}$	max.	600	800	1000	1200	1400	1600 V
Repetitive peak voltages	$V_{DRM}/V_{RRM}$	max.	600	800	1000	1200	1400	1600 V
Crest working voltages	$V_{DWM}/V_{RWM}$	max.	400	600	700	800	800	800 V*
Average on-state current (averaged over any 20 ms period) up to $T_{mb} = 85$ °C					$I_T(AV)$	max.	90 A	
R.M.S. on-state current					$I_T(RMS)$	max.	140 A	
Repetitive peak on-state current					$I_{TRM}$	max.	1250 A	
Non-repetitive peak on-state current; $t = 10$ ms; half sine-wave; $T_j = 125$ °C prior to surge; with reapplied $V_{RWM}$ max					$I_{TSM}$	max.	2000 A	
$I^2t$ for fusing ( $t = 10$ ms)					$I^2t$	max.	20 000 A <sup>2</sup> s	
Rate of rise of on-state current after triggering with $I_G = 750$ mA to $I_T = 300$ A; $dI_G/dt = 1$ A/ $\mu$ s					$dI_T/dt$	max.	300 A/ $\mu$ s	
Rate of change of commutation current					see Fig. 14			
<b>Gate to cathode</b>								
Reverse peak voltage					$V_{RGM}$	max.	10 V	
Average power dissipation (averaged over any 20 ms period)					$P_{G(AV)}$	max.	2 W	
Peak power dissipation					$P_{GM}$	max.	10 W	
<b>Temperatures</b>								
Storage temperature					$T_{stg}$	-55 to + 125	°C	
Junction temperature					$T_j$	max.	125 °C	
<b>THERMAL RESISTANCE</b>								
From junction to mounting base					$R_{th\ j-mb}$	=	0,3 °C/W	
From mounting base to heatsink					$R_{th\ mb-h}$	=	0,1 °C/W	
Transient thermal impedance ( $t = 1$ ms)					$Z_{th\ j-mb}$	=	0,015 °C/W	

\* To ensure thermal stability:  $R_{th\ j-a} < 0,75$  °C/W (d.c. blocking) or  $< 1,5$  °C/W (a.c.). For smaller heatsinks  $T_j$  max should be derated. For a.c. see Fig. 4.

**CHARACTERISTICS****Anode to cathode****On-state voltage** $I_T = 500 \text{ A}; T_j = 25^\circ\text{C}$  $V_T < 2,2 \text{ V}^*$ 

Rate of rise of off-state voltage that will not trigger any device; exponential method;  $V_D = 2/3 V_{DRM} \text{ max}$ ;  $T_j = 125^\circ\text{C}$

 $dV_D/dt < 200 \text{ V}/\mu\text{s}$ **Reverse current** $V_R = V_{RWM} \text{ max}; T_j = 125^\circ\text{C}$  $I_R < 15 \text{ mA}$ **Off-state current** $V_D = V_{DWM} \text{ max}; T_j = 125^\circ\text{C}$  $I_D < 15 \text{ mA}$ Holding current;  $T_j = 25^\circ\text{C}$  $I_H < 200 \text{ mA}$ **Gate to cathode****Voltage that will trigger all devices** $V_D = 6 \text{ V}; T_j = 25^\circ\text{C}$  $V_{GT} > 2,5 \text{ V}$ **Voltage that will not trigger any device** $V_D = V_{DRM} \text{ max}; T_j = 125^\circ\text{C}$  $V_{GD} < 250 \text{ mV}$ **Current that will trigger any device** $V_D = 6 \text{ V}; T_j = 25^\circ\text{C}$  $I_{GT} > 150 \text{ mA}$ **Switching characteristics**

Gate-controlled turn-on time ( $t_{gt} = t_d + t_r$ ) when switched from  $V_D = V_{DWM} \text{ max}$  to  $I_T = 100 \text{ A}$ ;  
 $I_{GT} = 200 \text{ mA}$ ;  $dI_G/dt = 1 \text{ A}/\mu\text{s}; T_j = 25^\circ\text{C}$

$t_{gt}$	<	2,5 $\mu\text{s}$
$t_r$	typ.	1 $\mu\text{s}$

\* Measured under pulse conditions to avoid excessive dissipation.

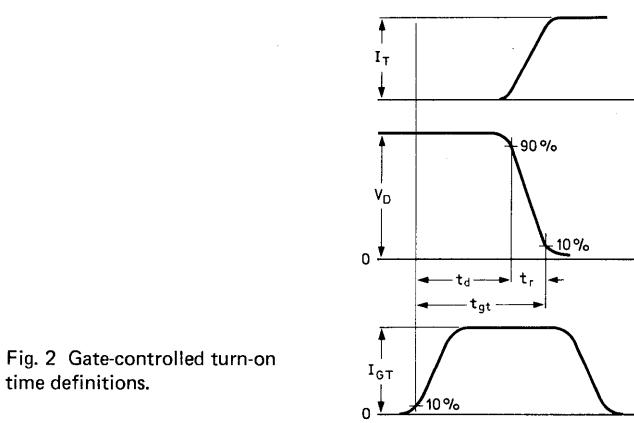


Fig. 2 Gate-controlled turn-on time definitions.

**CHARACTERISTICS** (continued)

Circuit-commutated turn-off when switched

from  $I_T = 50 \text{ A}$  to  $V_R \geq 50 \text{ V}$  with  $-dI_T/dt = 50 \text{ A}/\mu\text{s}$ ;

$dV_D/dt = 200 \text{ V}/\mu\text{s}$ ;

$T_j = 125^\circ\text{C}$

$t_q$	typ.	$100 \mu\text{s}$
	<	$200 \mu\text{s}$
$t_q$	typ.	$60 \mu\text{s}$
	<	$120 \mu\text{s}$

$T_j = 25^\circ\text{C}$

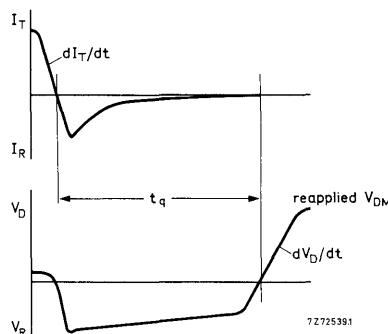


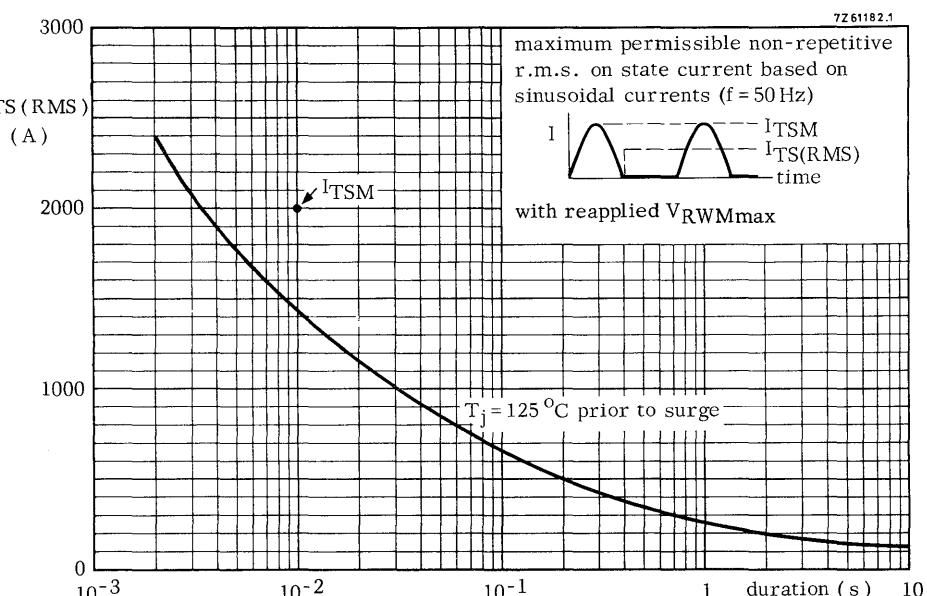
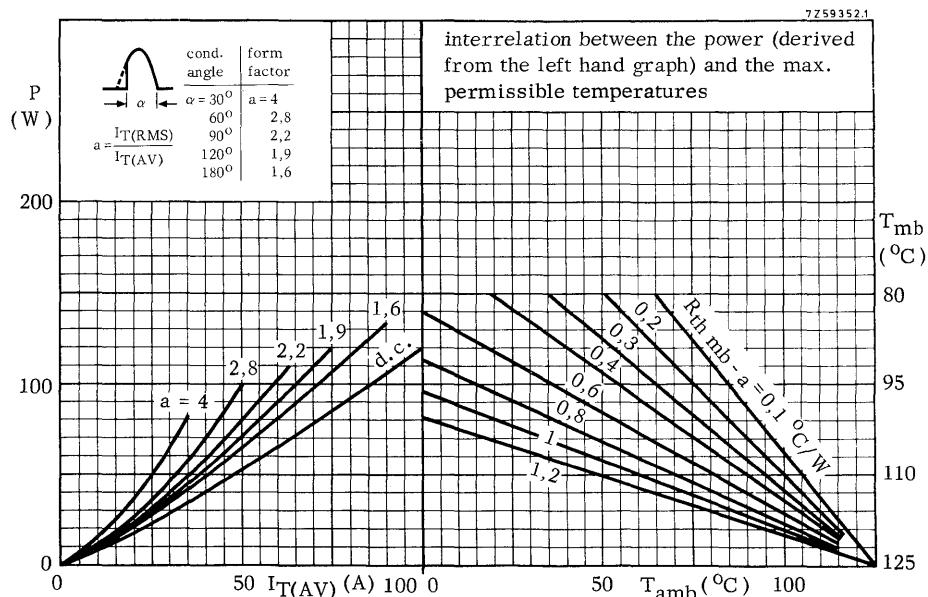
Fig. 3 Circuit-commutated turn-off time definition.

**OPERATING NOTE****Switching losses in commutation**

For applications in which the thyristor is forced to switch from an on-state current  $I_{TRM}$  to a high reverse voltage at a high commutation rate ( $-dI_T/dt$ ), consult Fig. 14 (nomogram) to find the increase in total average power. This increase must be added to the loss from the curves in Fig. 4.

**ORDERING NOTE**

Types with  $dV_D/dt$  of  $1000 \text{ V}/\mu\text{s}$  are available on request. Add suffix C to the type number when ordering; e.g. BTW23-600RC.



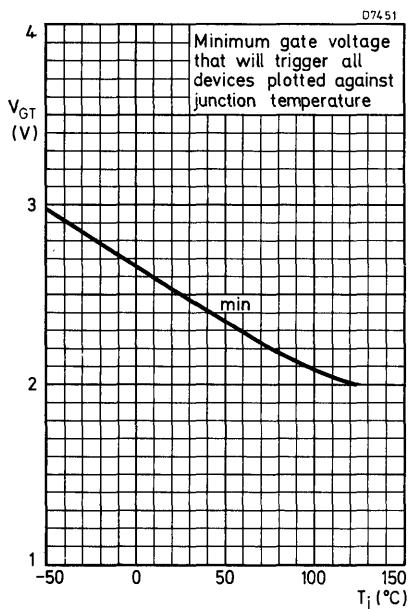


Fig. 6.

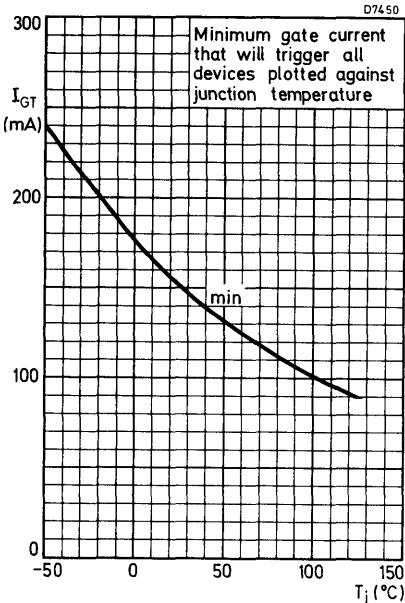


Fig. 7.

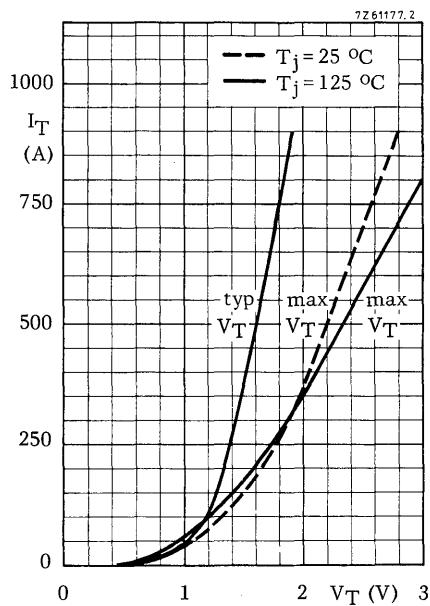


Fig. 8.

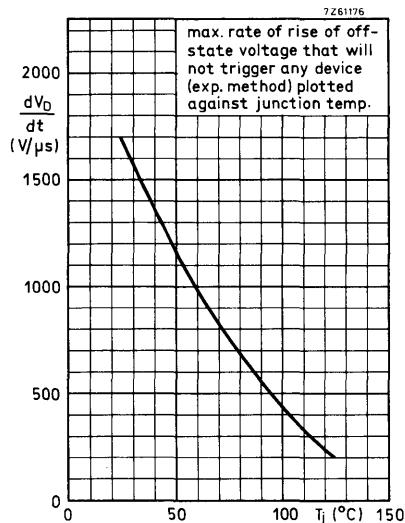


Fig. 9.

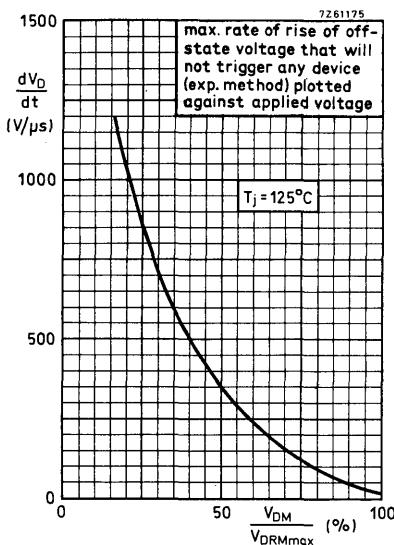


Fig. 10.

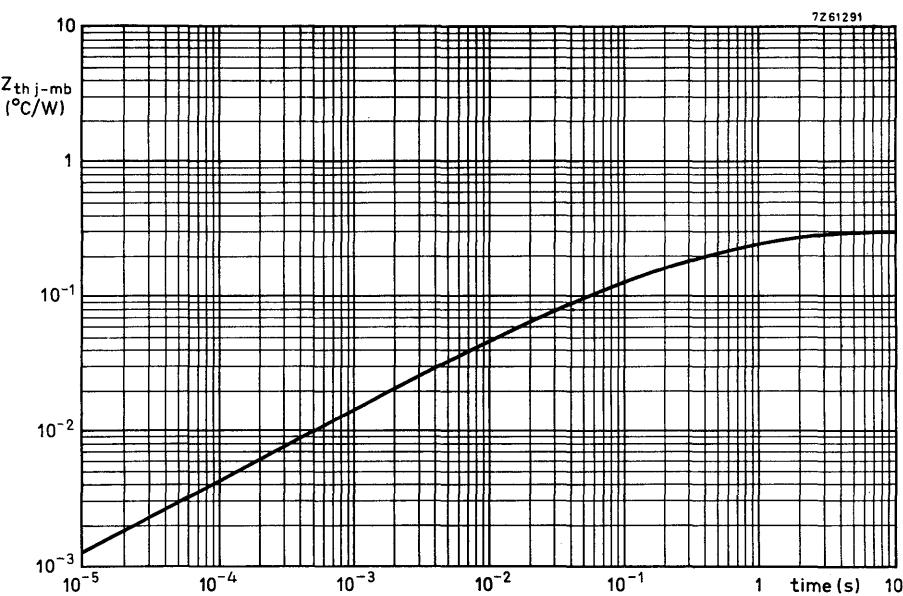


Fig. 11.

# BTW23 SERIES

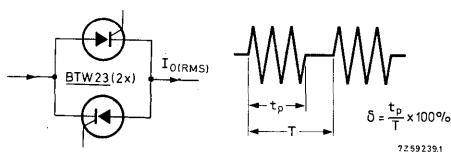
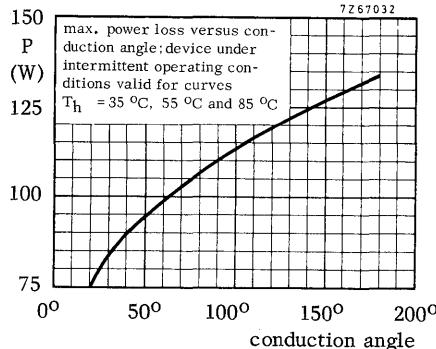
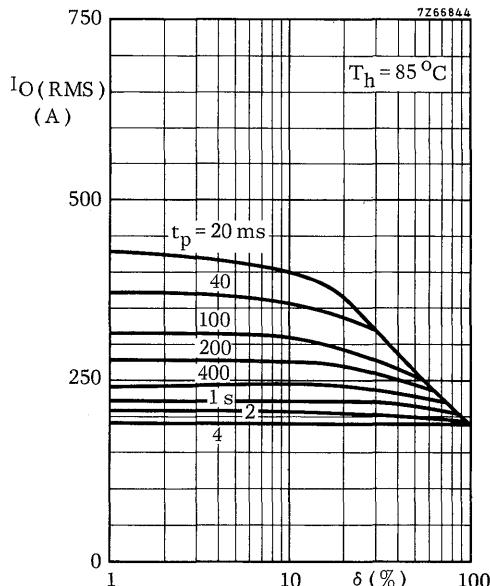
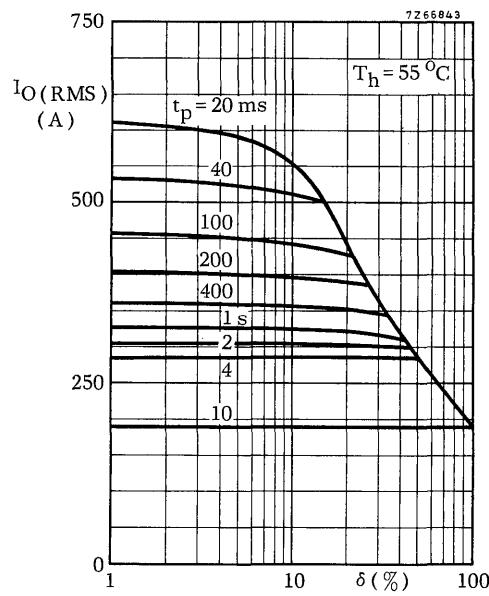
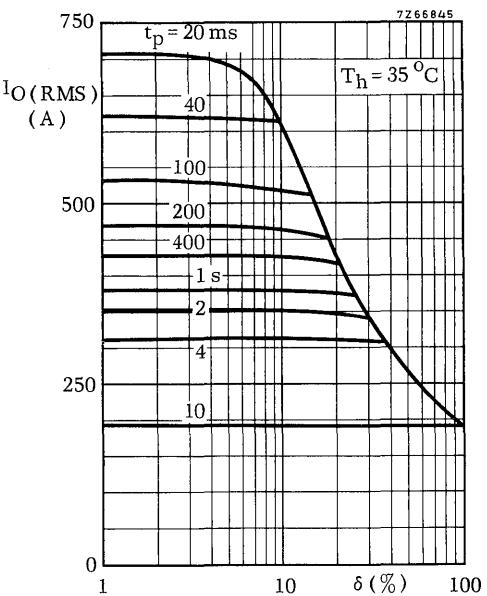


Fig. 12 Intermittent overload capability of two BTW23 thyristors in anti-parallel connection in a single phase a.c. control circuit (e.g. welding); conduction angle 360°.

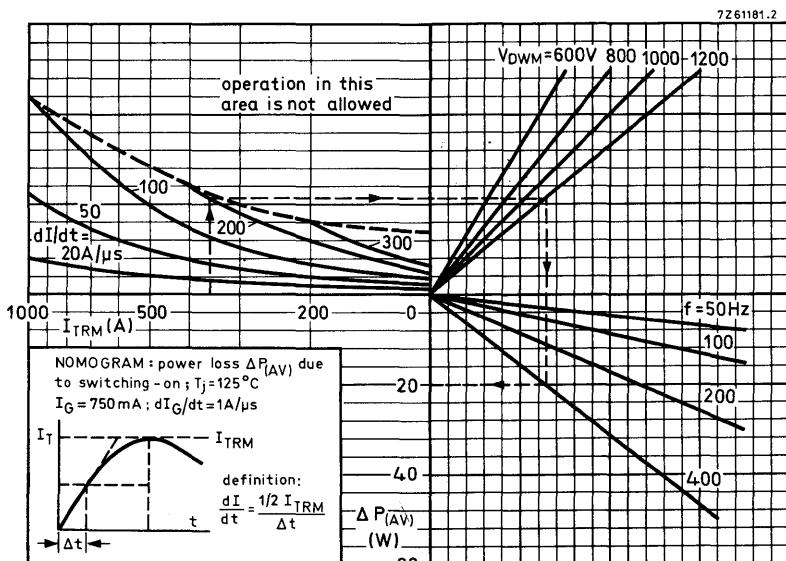


Fig. 13.

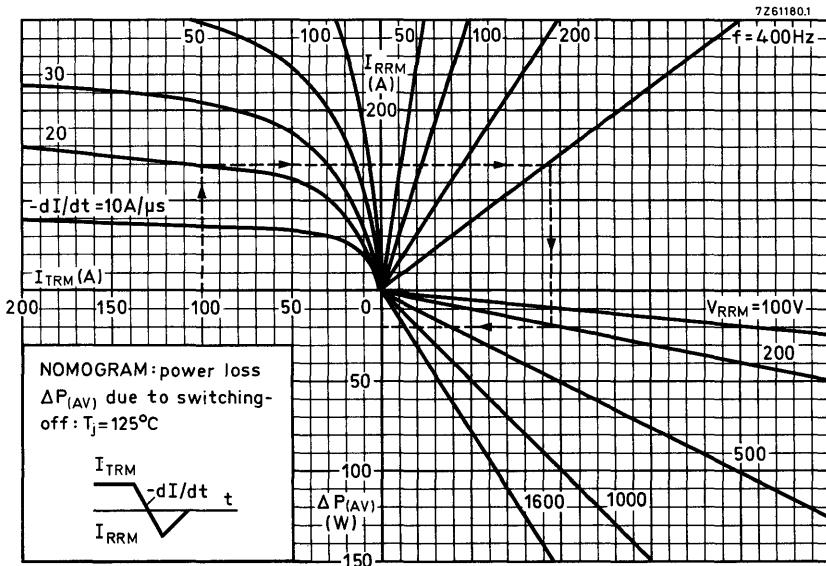


Fig. 14.

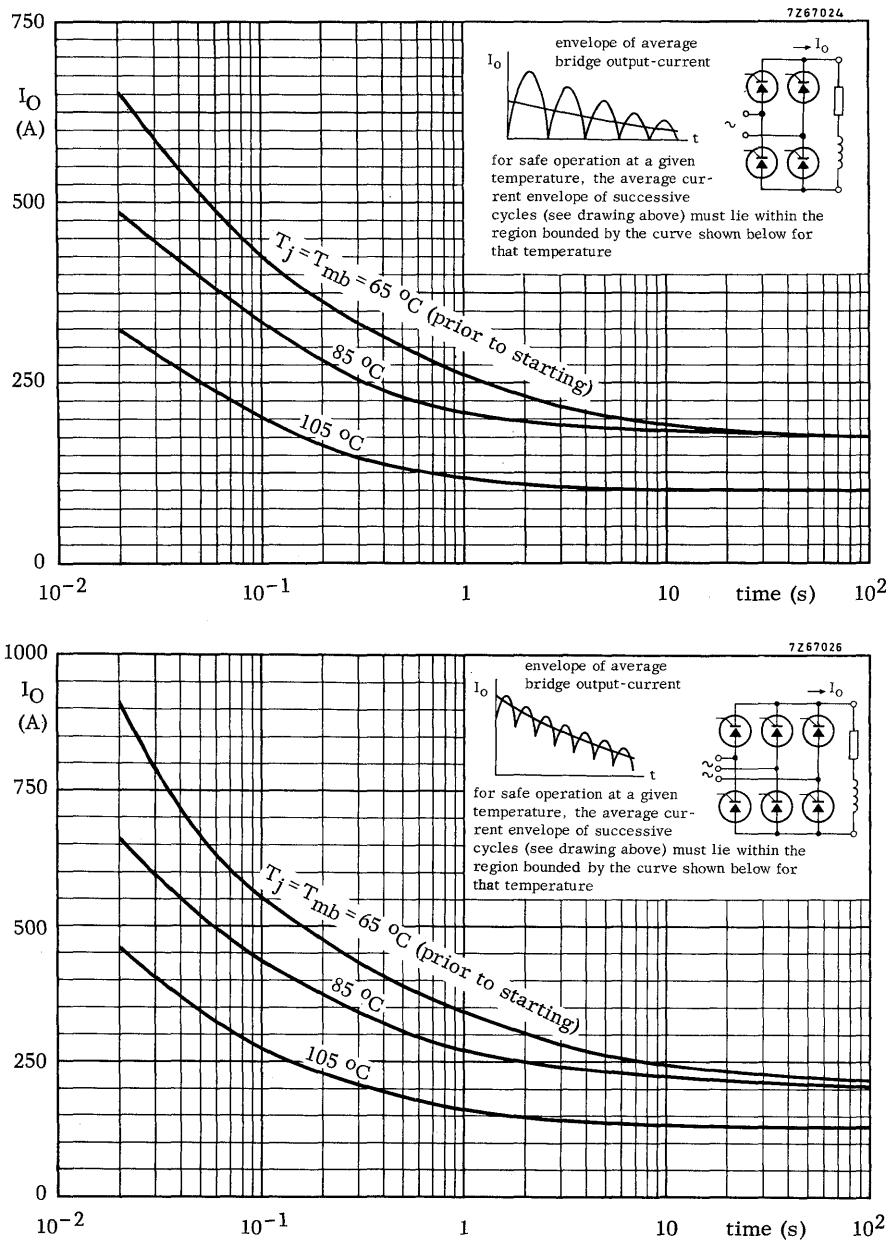


Fig. 15 Limits for starting or inrush currents.